Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/679,682	TUCKER ET AL.	
Examiner	**Art Unit**	
Eric B. Chen	1765	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Performed inventor search for double patenting (PALM, eDAN)	6/2/2005	EC
PLUS Search	6/2/2005	EC
EAST (all databases) - See Search History Printout	6/2/2005	EC
STIC Search	6/25/2005	EC
252/79.1-79.3; 438/745; 216/100,102,105,108,109 (text seach only - see search history printout) (consulted Shamim Ahmed)	6/28/2005	EC